



# THE DATASHEET OF SN74AUP1G80DBVT



## SN74AUP1G80 Low-Power Single Positive-Edge-Triggered D-Type Flip-Flop

### 1 Features

- Latch-Up Performance Exceeds 100 mA Per JESD 78, Class II
- ESD Performance Tested Per JESD 22
  - 2000-V Human-Body Model (A114-B, Class II)
  - 1000-V Charged-Device Model (C101)
- Available in the Texas Instruments NanoStar™ Package
- Low Static-Power Consumption ( $I_{CC} = 0.9 \mu\text{A}$  Maximum)
- Low Dynamic-Power Consumption ( $C_{pd} = 4.3 \text{ pF}$  Typical at 3.3 V)
- Low Input Capacitance ( $C_i = 1.5 \text{ pF}$  Typical)
- Low Noise – Overshoot and Undershoot <10% of  $V_{CC}$
- $I_{off}$  Supports Partial-Power-Down Mode Operation
- Schmitt-Trigger Action Allows Slow Input Transition and Better Switching Noise Immunity at the Input ( $V_{hys} = 250 \text{ mV}$  Typical at 3.3 V)
- Wide Operating  $V_{CC}$  Range of 0.8 V to 3.6 V
- Optimized for 3.3-V Operation
- 3.6-V I/O Tolerant to Support Mixed-Mode Signal Operation
- $t_{pd} = 4.4 \text{ ns}$  Maximum at 3.3 V
- Suitable for Point-to-Point Applications

### 2 Applications

- Home Automation
- Factory Automation
- Test and Measurement
- Enterprise Switching
- Telecom Infrastructure
- Personal Electronics
- White Goods

### 3 Description

The AUP family is TI's premier solution to the industry's low-power needs in battery-powered portable applications. This family assures a low static- and dynamic-power consumption across the entire  $V_{CC}$  range of 0.8 V to 3.6 V, resulting in increased battery life (see [AUP – The Lowest-Power Family](#)). This product also maintains excellent signal integrity (see [Excellent Signal Integrity](#)).

This is a single positive-edge-triggered D-type flip-flop. When data at the data (D) input meets the setup time requirement, the data is transferred to the  $\bar{Q}$  output on the positive-going edge of the clock pulse. Clock triggering occurs at a voltage level and is not directly related to the rise time of the clock pulse. Following the hold-time interval, data at the D input can be changed without affecting the levels at the outputs.

NanoStar™ package technology is a major breakthrough in IC packaging concepts, using the die as the package.

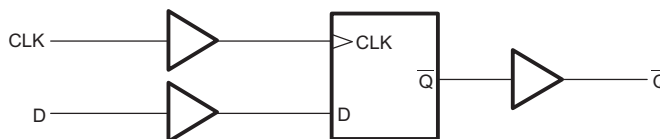
This device is fully specified for partial-power-down applications using  $I_{off}$ . The  $I_{off}$  circuitry disables the outputs when the device is powered down. This inhibits current backflow into the device which prevents damage to the device.

#### Device Information<sup>(1)</sup>

PART NUMBER	PACKAGE	BODY SIZE (NOM)
SN74AUP1G80DBV	SOT-23 (5)	1.60 mm × 2.90 mm
SN74AUP1G80DCK	SC70 (5)	1.25 mm × 2.00 mm
SN74AUP1G80DRY	SON (6)	1.00 mm × 1.45 mm
SN74AUP1G80DSF	SON (6)	1.00 mm × 1.00 mm
SN74AUP1G80YFP	DSBGA (6)	0.76 mm × 1.16 mm
SN74AUP1G80YZP	DSBGA (5)	0.89 mm × 1.39 mm
SN74AUP1G80DPW	X2SON (5)	0.80 mm × 0.80 mm

(1) For all available packages, see the orderable addendum at the end of the data sheet.

#### Logic Diagram (Positive Logic)



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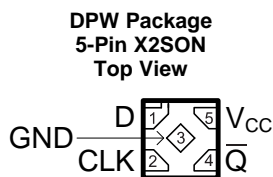
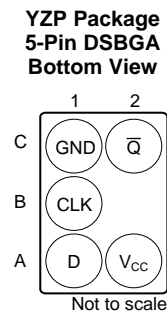
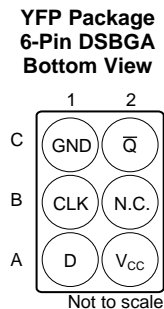
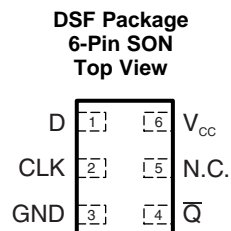
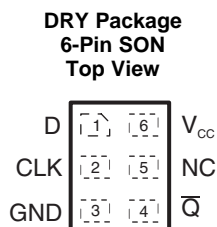
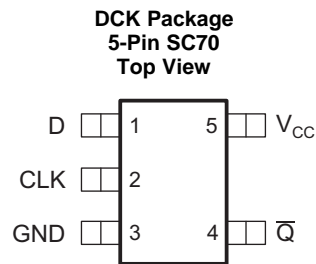
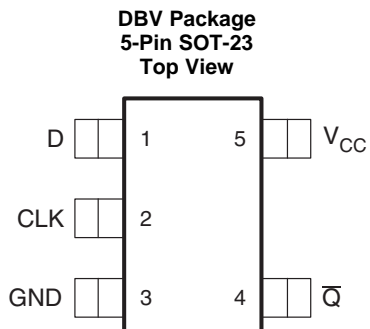
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## 4 Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

Changes from Revision E (May 2010) to Revision F	Page
• Added DPW (X2SON) package .....	<b>1</b>
• Added <i>Device Information</i> table, <i>Pin Configuration and Functions</i> section, <i>ESD Ratings</i> table, <i>Thermal Information</i> table, <i>Feature Description</i> section, <i>Device Functional Modes</i> , <i>Application and Implementation</i> section, <i>Power Supply Recommendations</i> section, <i>Layout</i> section, <i>Device and Documentation Support</i> section, and <i>Mechanical, Packaging, and Orderable Information</i> section .....	<b>1</b>
• Deleted <i>Ordering Information</i> table, see <i>Mechanical, Packaging, and Orderable Information</i> at the end of the data sheet .....	<b>1</b>
• Added Junction temperature, $T_J$ in <i>Absolute Maximum Ratings</i> table .....	<b>4</b>

## 5 Pin Configuration and Functions



### Pin Functions

NAME	PIN					I/O	DESCRIPTION
	DBV, DCK	DRY, DSF	YFP	YZP	DPW		
D	1	1	A1	A1	1	I	Data input
CLK	2	2	B1	B1	2	I	Positive-Edge-Triggered Clock input
GND	3	3	C1	C1	3	—	Ground pin
$\bar{Q}$	4	4	C2	C2	4	O	Inverted output
NC	—	5	B2	—	—	—	No Internal Connection
V <sub>CC</sub>	5	6	A2	A2	5	—	Positive Supply

## 6 Specifications

### 6.1 Absolute Maximum Ratings

 over operating free-air temperature range (unless otherwise noted)<sup>(1)</sup>

		MIN	MAX	UNIT
V <sub>CC</sub>	Supply voltage	-0.5	4.6	V
V <sub>I</sub>	Input voltage <sup>(2)</sup>	-0.5	4.6	V
V <sub>O</sub>	Voltage range applied to any output in the high-impedance or power-off state <sup>(2)</sup>	-0.5	4.6	V
V <sub>O</sub>	Voltage range applied to any output in the high or low state <sup>(2)</sup>	-0.5	V <sub>CC</sub> + 0.5	V
I <sub>IK</sub>	Input clamp current	V <sub>I</sub> < 0	-50	mA
I <sub>OK</sub>	Output clamp current	V <sub>O</sub> < 0	-50	mA
I <sub>O</sub>	Continuous output current		±20	mA
	Continuous current through V <sub>CC</sub> or GND		±50	mA
T <sub>J</sub>	Junction temperature		150	°C
T <sub>stg</sub>	Storage temperature	-65	150	°C

(1) Stresses beyond those listed under *Absolute Maximum Ratings* may cause permanent damage to the device. These are stress ratings only, which do not imply functional operation of the device at these or any other conditions beyond those indicated under *Recommended Operating Conditions*. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

(2) The input negative-voltage and output voltage ratings may be exceeded if the input and output current ratings are observed.

### 6.2 ESD Ratings

		VALUE	UNIT
V <sub>(ESD)</sub>	Electrostatic discharge	Human-body model (HBM), per ANSI/ESDA/JEDEC JS-001 <sup>(1)</sup>	2000
		Charged-device model (CDM), per JEDEC specification JESD22-C101 <sup>(2)</sup>	1000

(1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.

(2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.

### 6.3 Recommended Operating Conditions

 See <sup>(1)</sup>

		MIN	MAX	UNIT
V <sub>CC</sub>	Supply voltage	0.8	3.6	V
V <sub>IH</sub>	High-level input voltage	V <sub>CC</sub> = 0.8 V	V <sub>CC</sub>	V
		V <sub>CC</sub> = 1.1 V to 1.95 V	0.65 × V <sub>CC</sub>	
		V <sub>CC</sub> = 2.3 V to 2.7 V	1.6	
		V <sub>CC</sub> = 3 V to 3.6 V	2	
V <sub>IL</sub>	Low-level input voltage	V <sub>CC</sub> = 0.8 V	0	V
		V <sub>CC</sub> = 1.1 V to 1.95 V	0.35 × V <sub>CC</sub>	
		V <sub>CC</sub> = 2.3 V to 2.7 V	0.7	
		V <sub>CC</sub> = 3 V to 3.6 V	0.9	
V <sub>I</sub>	Input voltage	0	3.6	V
V <sub>O</sub>	Output voltage	0	V <sub>CC</sub>	V
I <sub>OH</sub>	High-level output current <sup>(2)</sup>	V <sub>CC</sub> = 0.8 V	-20	mA
		V <sub>CC</sub> = 1.1 V	-1.1	
		V <sub>CC</sub> = 1.4 V	-1.7	
		V <sub>CC</sub> = 1.65	-1.9	
		V <sub>CC</sub> = 2.3 V	-3.1	
		V <sub>CC</sub> = 3 V	-4	

(1) All unused inputs of the device must be held at V<sub>CC</sub> or GND to assure proper device operation. See *Implications of Slow or Floating CMOS Inputs*, SCBA004.

(2) Defined by the signal integrity requirements and design-goal priorities.

## Recommended Operating Conditions (continued)

See <sup>(1)</sup>

		MIN	MAX	UNIT	
$I_{OL}$	Low-level output current <sup>(2)</sup>	$V_{CC} = 0.8\text{ V}$	20	$\mu\text{A}$	
		$V_{CC} = 1.1\text{ V}$	1.1	mA	
		$V_{CC} = 1.4\text{ V}$	1.7		
		$V_{CC} = 1.65\text{ V}$	1.9		
		$V_{CC} = 2.3\text{ V}$	3.1		
		$V_{CC} = 3\text{ V}$	4		
$\Delta t/\Delta v$	Input transition rise or fall rate	$V_{CC} = 0.8\text{ V to }3.6\text{ V}$		200	ns/V
$T_A$	Operating free-air temperature	-40	85	°C	

## 6.4 Thermal Information

THERMAL METRIC <sup>(1)</sup>	SN74AUP1G80							UNIT	
	DBV (SOT)	DCK (SC70)	DRY (SON)	DSF (SON)	YFP (DSBGA)	YZP (DSBGA)	DPW (X2SON)		
	5 PINS	5 PINS	6 PINS	6 PINS	6 PINS	5 PINS	5 PINS		
$R_{\theta JA}$	Junction-to-ambient thermal resistance	267.2	284.1	341.1	377.1	125.4	146.2	489.2	°C/W
$R_{\theta JC(top)}$	Junction-to-case (top) thermal resistance	191.9	208.5	233.1	187.7	1.9	1.4	226.3	°C/W
$R_{\theta JB}$	Junction-to-board thermal resistance	101.1	103.1	206.7	236.6	37.2	39.3	352.9	°C/W
$\Psi_{JT}$	Junction-to-top characterization parameter	83.0	76.6	63.4	29.0	0.5	0.7	38.2	°C/W
$\Psi_{JB}$	Junction-to-board characterization parameter	100.8	102.3	206.7	236.3	37.5	39.8	352.1	°C/W
$R_{\theta JC(bot)}$	Junction-to-case (bottom) thermal resistance	n/a	n/a	n/a	n/a	n/a	n/a	150.8	°C/W

(1) For more information about traditional and new thermal metrics, see the [Semiconductor and IC Package Thermal Metrics](#) application report.

## 6.5 Electrical Characteristics: $T_A = 25^\circ\text{C}$

 over recommended operating free-air temperature range,  $T_A = 25^\circ\text{C}$  (unless otherwise noted)

PARAMETER	TEST CONDITIONS	$V_{CC}$	MIN	TYP	MAX	UNIT
$V_{OH}$	$I_{OH} = -20\ \mu\text{A}$	0.8 V to 3.6 V	$V_{CC} - 0.1$			V
	$I_{OH} = -1.1\ \text{mA}$	1.1 V	$0.75 \times V_{CC}$			
	$I_{OH} = -1.7\ \text{mA}$	1.4 V	1.11			
	$I_{OH} = -1.9\ \text{mA}$	1.65 V	1.32			
	$I_{OH} = -2.3\ \text{mA}$	2.3 V	2.05			
	$I_{OH} = -3.1\ \text{mA}$		1.9			
	$I_{OH} = -2.7\ \text{mA}$	3 V	2.72			
	$I_{OH} = -4\ \text{mA}$		2.6			
$V_{OL}$	$I_{OL} = 20\ \mu\text{A}$	0.8 V to 3.6 V			0.1	V
	$I_{OL} = 1.1\ \text{mA}$	1.1 V			$0.3 \times V_{CC}$	
	$I_{OL} = 1.7\ \text{mA}$	1.4 V			0.31	
	$I_{OL} = 1.9\ \text{mA}$	1.65 V			0.31	
	$I_{OL} = 2.3\ \text{mA}$	2.3 V			0.31	
	$I_{OL} = 3.1\ \text{mA}$				0.44	
	$I_{OL} = 2.7\ \text{mA}$	3 V			0.31	
	$I_{OL} = 4\ \text{mA}$				0.44	
$I_I$ D or CLK input	$V_I = \text{GND to } 3.6\ \text{V}$	0 V to 3.6 V			0.1	$\mu\text{A}$
$I_{off}$	$V_I$ or $V_O = 0\ \text{V to } 3.6\ \text{V}$	0 V			0.2	$\mu\text{A}$
$\Delta I_{off}$	$V_I$ or $V_O = 0\ \text{V to } 3.6\ \text{V}$	0 V to 0.2 V			0.2	$\mu\text{A}$
$I_{CC}$	$V_I = \text{GND or } V_{CC} \text{ to } 3.6\ \text{V}, I_O = 0$	0.8 V to 3.6 V			0.5	$\mu\text{A}$
$\Delta I_{CC}$	$V_I = V_{CC} - 0.6\ \text{V},^{(1)} I_O = 0$	3.3 V			40	$\mu\text{A}$
$C_i$	$V_I = V_{CC} \text{ or GND}$	0 V	1.5			pF
		3.6 V	1.5			
$C_o$	$V_O = \text{GND}$	0 V	3			pF

 (1) One input at  $V_{CC} - 0.6\ \text{V}$ , other input at  $V_{CC}$  or GND

## 6.6 Electrical Characteristics: $T_A = -40^\circ\text{C}$ to $+85^\circ\text{C}$

over recommended operating free-air temperature range,  $T_A = -40^\circ\text{C}$  to  $+85^\circ\text{C}$  (unless otherwise noted)

PARAMETER	TEST CONDITIONS	$V_{CC}$	MIN	MAX	UNIT
$V_{OH}$	$I_{OH} = -20\ \mu\text{A}$	0.8 V to 3.6 V	$V_{CC} - 0.1$		V
	$I_{OH} = -1.1\ \text{mA}$	1.1 V	$0.7 \times V_{CC}$		
	$I_{OH} = -1.7\ \text{mA}$	1.4 V	1.03		
	$I_{OH} = -1.9\ \text{mA}$	1.65 V	1.3		
	$I_{OH} = -2.3\ \text{mA}$	2.3 V	1.97		
	$I_{OH} = -3.1\ \text{mA}$		1.85		
	$I_{OH} = -2.7\ \text{mA}$	3 V	2.67		
	$I_{OH} = -4\ \text{mA}$		2.55		
$V_{OL}$	$I_{OL} = 20\ \mu\text{A}$	0.8 V to 3.6 V		0.1	V
	$I_{OL} = 1.1\ \text{mA}$	1.1 V		$0.3 \times V_{CC}$	
	$I_{OL} = 1.7\ \text{mA}$	1.4 V		0.37	
	$I_{OL} = 1.9\ \text{mA}$	1.65 V		0.35	
	$I_{OL} = 2.3\ \text{mA}$	2.3 V		0.33	
	$I_{OL} = 3.1\ \text{mA}$			0.45	
	$I_{OL} = 2.7\ \text{mA}$	3 V		0.33	
	$I_{OL} = 4\ \text{mA}$			0.45	
$I_I$ D or CLK input	$V_I = \text{GND to } 3.6\ \text{V}$	0 V to 3.6 V		0.5	$\mu\text{A}$
$I_{off}$	$V_I$ or $V_O = 0\ \text{V to } 3.6\ \text{V}$	0 V		0.6	$\mu\text{A}$
$\Delta I_{off}$	$V_I$ or $V_O = 0\ \text{V to } 3.6\ \text{V}$	0 V to 0.2 V		0.6	$\mu\text{A}$
$I_{CC}$	$V_I = \text{GND or } V_{CC}\ \text{to } 3.6\ \text{V}, I_O = 0$	0.8 V to 3.6 V		0.9	$\mu\text{A}$
$\Delta I_{CC}$	$V_I = V_{CC} - 0.6\ \text{V}, I_O = 0$ <sup>(1)</sup>	3.3 V		50	$\mu\text{A}$

(1) One input at  $V_{CC} - 0.6\ \text{V}$ , other input at  $V_{CC}$  or GND

## 6.7 Timing Requirements

over recommended operating free-air temperature range,  $T_A = -40^\circ\text{C}$  to  $+85^\circ\text{C}$  (unless otherwise noted) (see [Figure 3](#))

		$V_{CC}$	MIN	TYP <sup>(1)</sup>	MAX	UNIT
$f_{clock}$	Clock frequency	0.8 V			20	MHz
		1.2 V $\pm$ 0.1 V			80	
		1.5 V $\pm$ 0.1 V			120	
		1.8 V $\pm$ 0.15 V			160	
		2.5 V $\pm$ 0.2 V			220	
		3.3 V $\pm$ 0.3 V			260	
$t_w$	Pulse duration, CLK high or low	0.8 V	5.5			
		1.2 V $\pm$ 0.1 V	2.5			
		1.5 V $\pm$ 0.1 V	1.5			
		1.8 V $\pm$ 0.15 V	1.6			
		2.5 V $\pm$ 0.2 V	1.7			
		3.3 V $\pm$ 0.3 V	1.9			

(1)  $T_A = 25^\circ\text{C}$

**Timing Requirements (continued)**

 over recommended operating free-air temperature range,  $T_A = -40^{\circ}\text{C}$  to  $+85^{\circ}\text{C}$  (unless otherwise noted) (see [Figure 3](#))

		$V_{CC}$	MIN	TYP <sup>(1)</sup>	MAX	UNIT
$t_{su}$	Setup time before CLK $\uparrow$	0.8 V	6.7	3.4		ns
		1.2 V $\pm$ 0.1 V	2.4			
		1.5 V $\pm$ 0.1 V	1.2			
		1.8 V $\pm$ 0.15 V	0.8			
		2.5 V $\pm$ 0.2 V	0.6			
		3.3 V $\pm$ 0.3 V	0.4			
	Data low	0.8 V	8.9	3.4		ns
		1.2 V $\pm$ 0.1 V	2			
		1.5 V $\pm$ 0.1 V	1.3			
		1.8 V $\pm$ 0.15 V	1.1			
		2.5 V $\pm$ 0.2 V	0.8			
		3.3 V $\pm$ 0.3 V	0.7			
$t_h$	Hold time, data after CLK $\uparrow$	0.8 V	1	0		ns
		1.2 V $\pm$ 0.1 V	0			
		1.5 V $\pm$ 0.1 V	0			
		1.8 V $\pm$ 0.15 V	0			
		2.5 V $\pm$ 0.2 V	0			
		3.3 V $\pm$ 0.3 V	0			

**6.8 Switching Characteristics:  $C_L = 5$  pF**

 over recommended operating free-air temperature range,  $C_L = 5$  pF (unless otherwise noted) (see [Figure 3](#) and [Figure 4](#))

PARAMETER	FROM (INPUT)	TO (OUTPUT)	TEST CONDITIONS		MIN	TYP	MAX	UNIT	
			$V_{CC}$	$T_A$					
$f_{max}$			0.8 V	25°C		91		MHz	
				-40°C to +85°C	90				
			1.2 V $\pm$ 0.1 V	25°C		175			
				-40°C to +85°C	220				
			1.5 V $\pm$ 0.1 V	25°C		237			
				-40°C to +85°C	230				
			1.8 V $\pm$ 0.15 V	25°C		269			
				-40°C to +85°C	240				
			2.5 V $\pm$ 0.2 V	25°C		280			
				-40°C to +85°C	250				
			3.3 V $\pm$ 0.3 V	25°C		280			
				-40°C to +85°C	260				
$t_{pd}$	CLK	$\bar{Q}$	0.8 V	25°C		17.2		ns	
				25°C	3.2	7.1	14.9		
			1.2 V $\pm$ 0.1 V	25°C		2.7			16.3
				-40°C to +85°C	2.1		10.3		
			1.5 V $\pm$ 0.1 V	25°C		1.9	5		9.8
				-40°C to +85°C	2.1		10.3		
			1.8 V $\pm$ 0.15 V	25°C		1.7	3.9		7.6
				-40°C to +85°C	1.6		8.1		
			2.5 V $\pm$ 0.2 V	25°C		1.4	2.8		5.3
				-40°C to +85°C	1.2		5.6		
			3.3 V $\pm$ 0.3 V	25°C		1.2	2.2		4.1
				-40°C to +85°C	1		4.4		

### 6.9 Switching Characteristics: $C_L = 10\text{ pF}$

 over recommended operating free-air temperature range,  $C_L = 10\text{ pF}$  (unless otherwise noted) (see [Figure 3](#) and [Figure 4](#))

PARAMETER	FROM (INPUT)	TO (OUTPUT)	TEST CONDITIONS		MIN	TYP	MAX	UNIT	
			$V_{CC}$	$T_A$					
$f_{max}$			$V_{CC} = 0.8\text{ V}$	$T_A = 25^\circ\text{C}$		68		MHz	
				$T_A = -40^\circ\text{C to } +85^\circ\text{C}$	70				
			$V_{CC} = 1.2\text{ V} \pm 0.1\text{ V}$	$T_A = 25^\circ\text{C}$		128			
				$T_A = -40^\circ\text{C to } +85^\circ\text{C}$	170				
			$V_{CC} = 1.5\text{ V} \pm 0.1\text{ V}$	$T_A = 25^\circ\text{C}$		189			
				$T_A = -40^\circ\text{C to } +85^\circ\text{C}$	220				
			$V_{CC} = 1.8\text{ V} \pm 0.15\text{ V}$	$T_A = 25^\circ\text{C}$		234			
				$T_A = -40^\circ\text{C to } +85^\circ\text{C}$	240				
			$V_{CC} = 2.5\text{ V} \pm 0.2\text{ V}$	$T_A = 25^\circ\text{C}$		273			
				$T_A = -40^\circ\text{C to } +85^\circ\text{C}$	250				
			$V_{CC} = 3.3\text{ V} \pm 0.3\text{ V}$	$T_A = 25^\circ\text{C}$		280			
				$T_A = -40^\circ\text{C to } +85^\circ\text{C}$	260				
$t_{pd}$	CLK	$\bar{Q}$	$V_{CC} = 0.8\text{ V}$	$T_A = 25^\circ\text{C}$		19.4		ns	
				$T_A = -40^\circ\text{C to } +85^\circ\text{C}$	4.4	8.2	16.2		
			$V_{CC} = 1.2\text{ V} \pm 0.1\text{ V}$	$T_A = 25^\circ\text{C}$		3.4			17.7
				$T_A = -40^\circ\text{C to } +85^\circ\text{C}$	3.6	5.8	10.7		
			$V_{CC} = 1.5\text{ V} \pm 0.1\text{ V}$	$T_A = 25^\circ\text{C}$		2.6			11.3
				$T_A = -40^\circ\text{C to } +85^\circ\text{C}$	2.9	4.6	8.4		
			$V_{CC} = 1.8\text{ V} \pm 0.15\text{ V}$	$T_A = 25^\circ\text{C}$		2.1			3
				$T_A = -40^\circ\text{C to } +85^\circ\text{C}$	2.2	3.3	5.9		
			$V_{CC} = 2.5\text{ V} \pm 0.2\text{ V}$	$T_A = 25^\circ\text{C}$		1.7			6.3
				$T_A = -40^\circ\text{C to } +85^\circ\text{C}$	1.9	2.7	4.7		
			$V_{CC} = 3.3\text{ V} \pm 0.3\text{ V}$	$T_A = 25^\circ\text{C}$		1.4			4.9
				$T_A = -40^\circ\text{C to } +85^\circ\text{C}$					

### 6.10 Switching Characteristics: $C_L = 15\text{ pF}$

 over recommended operating free-air temperature range,  $C_L = 15\text{ pF}$  (unless otherwise noted) (see [Figure 3](#) and [Figure 4](#))

PARAMETER	FROM (INPUT)	TO (OUTPUT)	TEST CONDITIONS		MIN	TYP	MAX	UNIT
			$V_{CC}$	$T_A$				
$f_{max}$			$V_{CC} = 0.8\text{ V}$	$T_A = 25^\circ\text{C}$		52		MHz
				$T_A = -40^\circ\text{C to } +85^\circ\text{C}$	50			
			$V_{CC} = 1.2\text{ V} \pm 0.1\text{ V}$	$T_A = 25^\circ\text{C}$		98		
				$T_A = -40^\circ\text{C to } +85^\circ\text{C}$	130			
			$V_{CC} = 1.5\text{ V} \pm 0.1\text{ V}$	$T_A = 25^\circ\text{C}$		148		
				$T_A = -40^\circ\text{C to } +85^\circ\text{C}$	180			
			$V_{CC} = 1.8\text{ V} \pm 0.15\text{ V}$	$T_A = 25^\circ\text{C}$		196		
				$T_A = -40^\circ\text{C to } +85^\circ\text{C}$	240			
			$V_{CC} = 2.5\text{ V} \pm 0.2\text{ V}$	$T_A = 25^\circ\text{C}$		249		
				$T_A = -40^\circ\text{C to } +85^\circ\text{C}$	250			
			$V_{CC} = 3.3\text{ V} \pm 0.3\text{ V}$	$T_A = 25^\circ\text{C}$		280		
				$T_A = -40^\circ\text{C to } +85^\circ\text{C}$	260			

**Switching Characteristics:  $C_L = 15\text{ pF}$  (continued)**

 over recommended operating free-air temperature range,  $C_L = 15\text{ pF}$  (unless otherwise noted) (see [Figure 3](#) and [Figure 4](#))

PARAMETER	FROM (INPUT)	TO (OUTPUT)	TEST CONDITIONS		MIN	TYP	MAX	UNIT
$t_{pd}$	CLK	$\bar{Q}$	$V_{CC} = 0.8\text{ V}$	$T_A = 25^\circ\text{C}$	21.5			ns
				$T_A = -40^\circ\text{C to } +85^\circ\text{C}$	3	9.1	17.4	
			$V_{CC} = 1.2\text{ V} \pm 0.1\text{ V}$		$T_A = 25^\circ\text{C}$	4.1		
				$T_A = -40^\circ\text{C to } +85^\circ\text{C}$	4.1		19	
			$V_{CC} = 1.5\text{ V} \pm 0.1\text{ V}$	$T_A = 25^\circ\text{C}$	3.2			
				$T_A = -40^\circ\text{C to } +85^\circ\text{C}$	3.2	6.5	11.7	
			$V_{CC} = 1.8\text{ V} \pm 0.15\text{ V}$	$T_A = 25^\circ\text{C}$	2.7			
				$T_A = -40^\circ\text{C to } +85^\circ\text{C}$	2.7	4.2	9.2	
			$V_{CC} = 2.5\text{ V} \pm 0.2\text{ V}$	$T_A = 25^\circ\text{C}$	2.2			
				$T_A = -40^\circ\text{C to } +85^\circ\text{C}$	2.1	3.8	6.5	
			$V_{CC} = 3.3\text{ V} \pm 0.3\text{ V}$	$T_A = 25^\circ\text{C}$	1.9			
				$T_A = -40^\circ\text{C to } +85^\circ\text{C}$	1.9	3.1	5.1	
			$T_A = -40^\circ\text{C to } +85^\circ\text{C}$	1.8		5.5		

**6.11 Switching Characteristics:  $C_L = 30\text{ pF}$** 

 over recommended operating free-air temperature range,  $C_L = 30\text{ pF}$  (unless otherwise noted) (see [Figure 3](#) and [Figure 4](#))

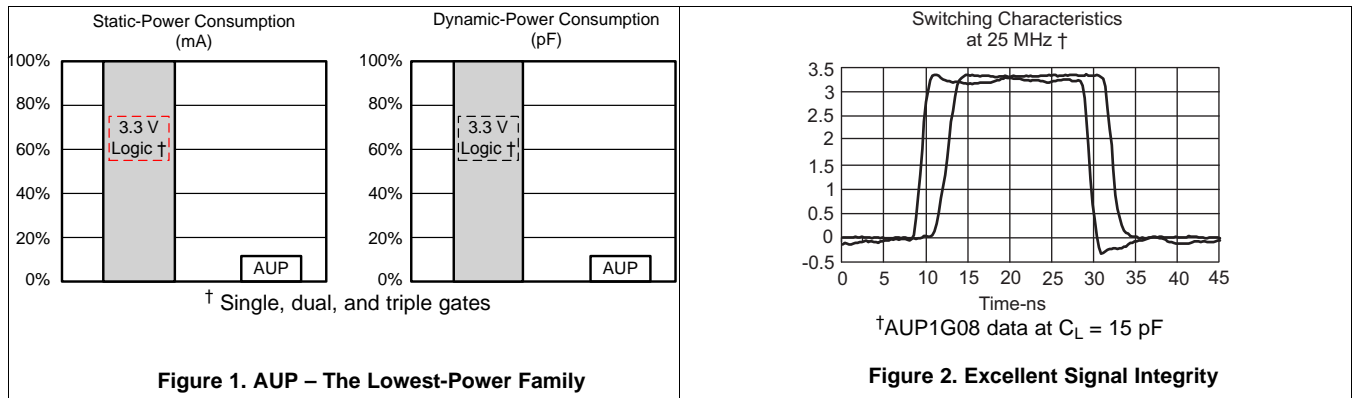
PARAMETER	FROM (INPUT)	TO (OUTPUT)	TEST CONDITIONS		MIN	TYP	MAX	UNIT
$f_{max}$			$V_{CC} = 0.8\text{ V}$	$T_A = 25^\circ\text{C}$	32			MHz
				$T_A = -40^\circ\text{C to } +85^\circ\text{C}$	20			
			$V_{CC} = 1.2\text{ V} \pm 0.1\text{ V}$	$T_A = 25^\circ\text{C}$	71			
				$T_A = -40^\circ\text{C to } +85^\circ\text{C}$	80			
			$V_{CC} = 1.5\text{ V} \pm 0.1\text{ V}$	$T_A = 25^\circ\text{C}$	104			
				$T_A = -40^\circ\text{C to } +85^\circ\text{C}$	120			
			$V_{CC} = 1.8\text{ V} \pm 0.15\text{ V}$	$T_A = 25^\circ\text{C}$	133			
				$T_A = -40^\circ\text{C to } +85^\circ\text{C}$	160			
			$V_{CC} = 2.5\text{ V} \pm 0.2\text{ V}$	$T_A = 25^\circ\text{C}$	181			
				$T_A = -40^\circ\text{C to } +85^\circ\text{C}$	220			
			$V_{CC} = 3.3\text{ V} \pm 0.3\text{ V}$	$T_A = 25^\circ\text{C}$	257			
				$T_A = -40^\circ\text{C to } +85^\circ\text{C}$	260			
$t_{pd}$	CLK	$\bar{Q}$	$V_{CC} = 0.8\text{ V}$	$T_A = 25^\circ\text{C}$	28.4			ns
				$T_A = -40^\circ\text{C to } +85^\circ\text{C}$	5.1	11.8	20.7	
			$V_{CC} = 1.2\text{ V} \pm 0.1\text{ V}$		$T_A = 25^\circ\text{C}$	6.2		
				$T_A = -40^\circ\text{C to } +85^\circ\text{C}$	6.2		28.7	
			$V_{CC} = 1.5\text{ V} \pm 0.1\text{ V}$	$T_A = 25^\circ\text{C}$	4.8			
				$T_A = -40^\circ\text{C to } +85^\circ\text{C}$	6.9	8.5	14.1	
			$V_{CC} = 1.8\text{ V} \pm 0.15\text{ V}$	$T_A = 25^\circ\text{C}$	4			
				$T_A = -40^\circ\text{C to } +85^\circ\text{C}$	4	6.9	11.2	
			$V_{CC} = 2.5\text{ V} \pm 0.2\text{ V}$	$T_A = 25^\circ\text{C}$	3.3			
				$T_A = -40^\circ\text{C to } +85^\circ\text{C}$	3.2	5.1	7.9	
			$V_{CC} = 3.3\text{ V} \pm 0.3\text{ V}$	$T_A = 25^\circ\text{C}$	2.9			
				$T_A = -40^\circ\text{C to } +85^\circ\text{C}$	2.9	4.2	6.4	
			$T_A = -40^\circ\text{C to } +85^\circ\text{C}$	2.8		7.5		

### 6.12 Operating Characteristics

T<sub>A</sub> = 25°C

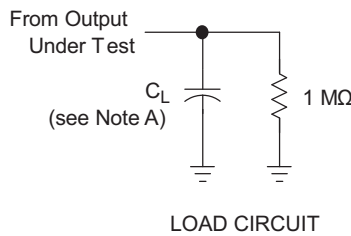
PARAMETER		TEST CONDITIONS	V <sub>CC</sub>	TYP	UNIT
C <sub>pd</sub>	Power dissipation capacitance	f = 10 MHz	0.8 V	4	pF
			1.2 V ± 0.1 V	4	
			1.5 V ± 0.1 V	4	
			1.8 V ± 0.15 V	4	
			2.5 V ± 0.2 V	4.1	
			3.3 V ± 0.3 V	4.3	

### 6.13 Typical Characteristics

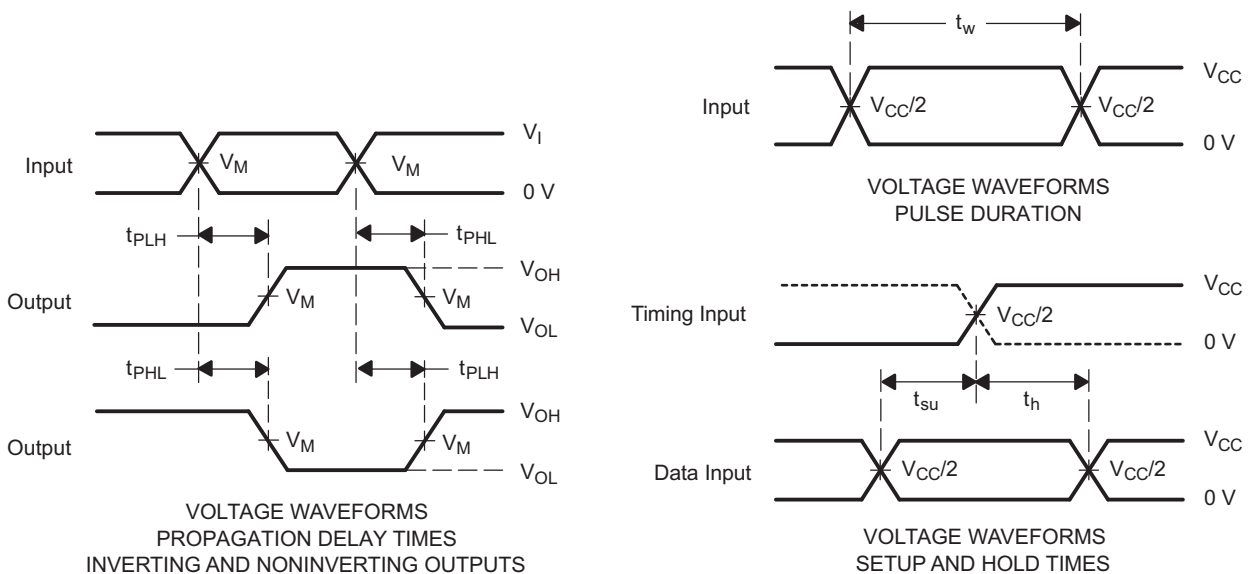


## 7 Parameter Measurement Information

### 7.1 Propagation Delays, Setup and Hold Times, and Pulse Duration



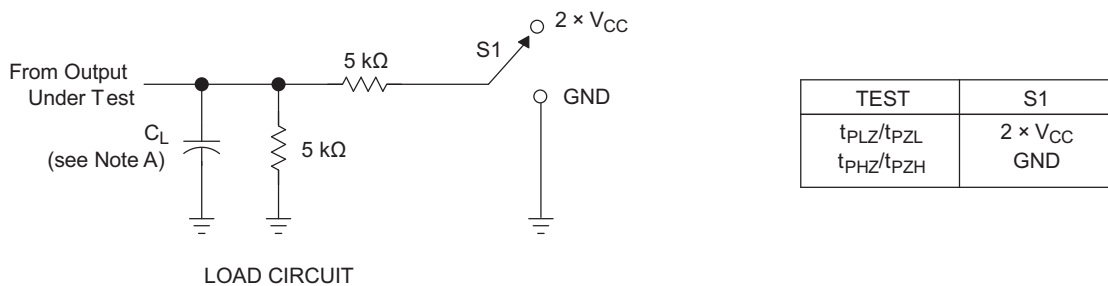
	$V_{CC} = 0.8\text{ V}$	$V_{CC} = 1.2\text{ V}$ $\pm 0.1\text{ V}$	$V_{CC} = 1.5\text{ V}$ $\pm 0.1\text{ V}$	$V_{CC} = 1.8\text{ V}$ $\pm 0.15\text{ V}$	$V_{CC} = 2.5\text{ V}$ $\pm 0.2\text{ V}$	$V_{CC} = 3.3\text{ V}$ $\pm 0.3\text{ V}$
$C_L$	5, 10, 15, 30 pF	5, 10, 15, 30 pF	5, 10, 15, 30 pF	5, 10, 15, 30 pF	5, 10, 15, 30 pF	5, 10, 15, 30 pF
$V_M$	$V_{CC}/2$	$V_{CC}/2$	$V_{CC}/2$	$V_{CC}/2$	$V_{CC}/2$	$V_{CC}/2$
$V_I$	$V_{CC}$	$V_{CC}$	$V_{CC}$	$V_{CC}$	$V_{CC}$	$V_{CC}$



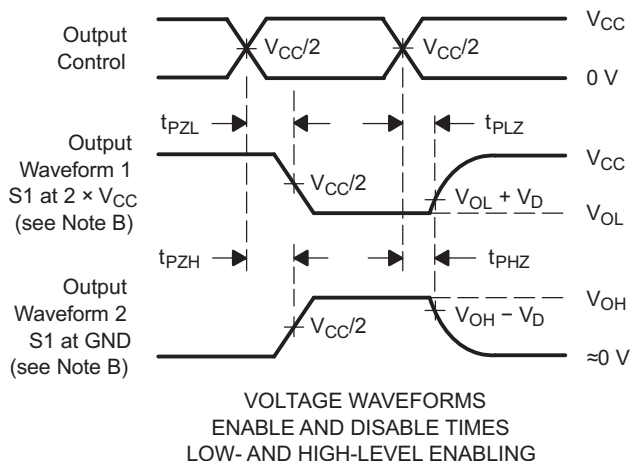
- NOTES:
- A.  $C_L$  includes probe and jig capacitance.
  - B. All input pulses are supplied by generators having the following characteristics:  $PRR \leq 10\text{ MHz}$ ,  $Z_O = 50\ \Omega$ ,  $t_r/t_f = 3\text{ ns}$ .
  - C. The outputs are measured one at a time, with one transition per measurement.
  - D.  $t_{PLH}$  and  $t_{PHL}$  are the same as  $t_{pd}$ .
  - E. All parameters and waveforms are not applicable to all devices.

Figure 3. Load Circuit and Voltage Waveforms

## 7.2 Enable and Disable Times



	$V_{CC} = 0.8 \text{ V}$	$V_{CC} = 1.2 \text{ V} \pm 0.1 \text{ V}$	$V_{CC} = 1.5 \text{ V} \pm 0.1 \text{ V}$	$V_{CC} = 1.8 \text{ V} \pm 0.15 \text{ V}$	$V_{CC} = 2.5 \text{ V} \pm 0.2 \text{ V}$	$V_{CC} = 3.3 \text{ V} \pm 0.3 \text{ V}$
$C_L$	5, 10, 15, 30 pF	5, 10, 15, 30 pF	5, 10, 15, 30 pF	5, 10, 15, 30 pF	5, 10, 15, 30 pF	5, 10, 15, 30 pF
$V_M$	$V_{CC}/2$	$V_{CC}/2$	$V_{CC}/2$	$V_{CC}/2$	$V_{CC}/2$	$V_{CC}/2$
$V_I$	$V_{CC}$	$V_{CC}$	$V_{CC}$	$V_{CC}$	$V_{CC}$	$V_{CC}$
$V_D$	0.1 V	0.1 V	0.1 V	0.15 V	0.15 V	0.3 V



- NOTES:
- A.  $C_L$  includes probe and jig capacitance.
  - B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high, except when disabled by the output control.
  - C. All input pulses are supplied by generators having the following characteristics:  $PRR \leq 10 \text{ MHz}$ ,  $Z_O = 50 \Omega$ ,  $t_r/t_f = 3 \text{ ns}$ .
  - D. The outputs are measured one at a time, with one transition per measurement.
  - E.  $t_{PLZ}$  and  $t_{PHZ}$  are the same as  $t_{dis}$ .
  - F.  $t_{PZL}$  and  $t_{PZH}$  are the same as  $t_{en}$ .
  - G. All parameters and waveforms are not applicable to all devices.

Figure 4. Load Circuit and Voltage Waveforms

## 8 Detailed Description

### 8.1 Overview

The SN74AUP1G80 is a single positive-edge-triggered D-type flip-flop. Data at the input (D) is transferred to the output ( $\bar{Q}$ ) on the positive-going edge of the clock pulse when the setup time requirement is met. Because the clock triggering occurs at a voltage level, it is not directly related to the rise time of the clock pulse. This allows for data at the input to be changed without affecting the level at the output, following the hold-time interval.

### 8.2 Functional Block Diagram

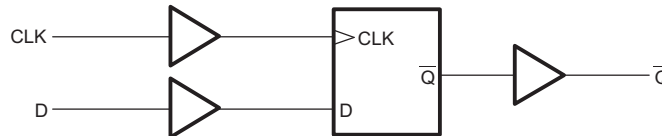


Figure 5. Logic Diagram (Positive Logic)

### 8.3 Feature Description

#### 8.3.1 Balanced CMOS Push-Pull Outputs

A balanced output allows the device to sink and source similar currents. The drive capability of this device may create fast edges into light loads so routing and load conditions should be considered to prevent ringing. Additionally, the outputs of this device are capable of driving larger currents than the device can sustain without being damaged. It is important for the power output of the device to be limited to avoid damage due to over-current. The electrical and thermal limits defined in the [Absolute Maximum Ratings](#) table must be followed at all times.

#### 8.3.2 Standard CMOS Inputs

Standard CMOS inputs are high impedance and are typically modeled as a resistor in parallel with the input capacitance given in the [Electrical Characteristics:  \$T\_A = 25^\circ\text{C}\$](#)  table. The worst case resistance is calculated with the maximum input voltage, given in the [Absolute Maximum Ratings](#) table, and the maximum input leakage current, given in the [Electrical Characteristics:  \$T\_A = 25^\circ\text{C}\$](#)  table, using ohm's law ( $R = V \div I$ ).

Signals applied to the inputs need to have fast edge rates, as defined by  $\Delta t/\Delta v$  in [Recommended Operating Conditions](#) table to avoid excessive currents and oscillations. If a slow or noisy input signal is required, a device with a Schmitt-trigger input should be used to condition the input signal prior to the standard CMOS input.

#### 8.3.3 Clamp Diodes

The inputs and outputs to this device have negative clamping diodes.

#### CAUTION

Voltages beyond the values specified in the [Absolute Maximum Ratings](#) table can cause damage to the device. The input negative-voltage and output voltage ratings may be exceeded if the input and output clamp-current ratings are observed.

## Feature Description (continued)

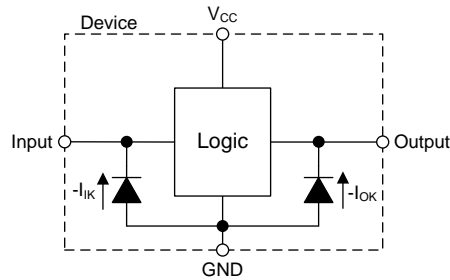


Figure 6. Electrical Placement of Clamping Diodes for Each Input and Output

### 8.3.4 Partial Power Down ( $I_{off}$ )

The inputs and outputs for this device enter a high-impedance state when the supply voltage is 0 V. The maximum leakage into or out of any input or output pin on the device is specified by  $I_{off}$  in the [Electrical Characteristics:  \$T\_A = 25^\circ\text{C}\$](#)  table.

### 8.3.5 Over-Voltage Tolerant Inputs

Input signals to this device can be driven above the supply voltage so long as they remain below the maximum input voltage value specified in the [Absolute Maximum Ratings](#) table.

## 8.4 Device Functional Modes

Table 1 lists the functional modes of the SN74AUP1G80 device.

Table 1. Function Table

INPUTS		OUTPUT
CLK	D	$\overline{Q}$
↑	H	L
↑	L	H
L or H	X	$\overline{Q}_0$

## 9 Application and Implementation

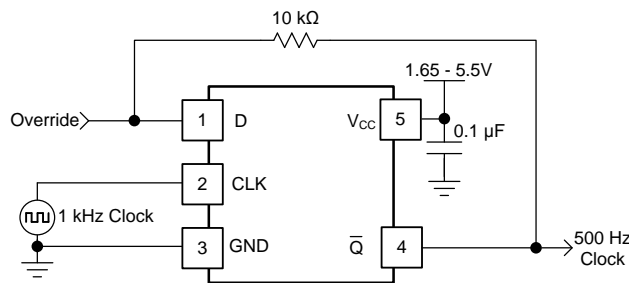
### NOTE

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

### 9.1 Application Information

A useful application for the SN74AUP1G80 is using it as a frequency divider. By feeding back the output ( $\bar{Q}$ ) to the input (D), the output toggles on every rising edge of the clock waveform. The output goes HIGH once every two clock cycles, so essentially the frequency of the clock signal is divided by a factor of two. The device does not have preset or clear functions so the initial state of the output is unknown. This application implements the use of an override pin to initially set the input HIGH or LOW. Initialization is not needed, but should be kept in mind. Post initialization, the Override input is set to a high-impedance mode, or it can be used to force a HIGH or LOW output.

### 9.2 Typical Application



**Figure 7. Clock Frequency Division**

#### 9.2.1 Design Requirements

For this application, a resistor must be placed on the feedback line in order for the initialization voltage from the override input to overpower the signal coming from the output ( $\bar{Q}$ ). Without a resistor the state at the input would be unknown as the output of the SN74AUP1G80 is driving the line separate from the Override input.

The SN74AUP1G80 device uses CMOS technology and has balanced output drive. Take care to avoid bus contention because it can drive currents that would exceed maximum limits.

#### 9.2.2 Detailed Design Procedure

1. Recommended input conditions:
  - For rise time and fall time specifications, see  $\Delta t/\Delta v$  in the [Recommended Operating Conditions](#) table.
  - For specified high and low levels, see  $V_{IH}$  and  $V_{IL}$  in the [Recommended Operating Conditions](#) table.
  - Input voltages are recommended to not go below 0 V and not exceed 4.6 V for any  $V_{CC}$ . See the [Absolute Maximum Ratings](#) table.
2. Recommended output conditions:
  - Load currents should not exceed  $\pm 20$  mA. See the [Absolute Maximum Ratings](#) table.
  - Output voltages are recommended to not go below 0 V and not exceed the  $V_{CC}$  voltage. See the [Absolute Maximum Ratings](#) table.
3. Feedback resistor:
  - A 10-k $\Omega$  resistor is chosen to bias the input so the Override input can initialize the input and output. The resistor value is important because a resistance too high, such as 1 M $\Omega$ , would cause too much of a voltage drop, causing the output to no longer be able to drive the input. On the other hand, a resistor too low, such as a 1  $\Omega$ , would not bias enough and might cause bus contention between the  $\bar{Q}$  output and the override input, possibly damaging the device.

## Typical Application (continued)

### 9.2.3 Application Curve

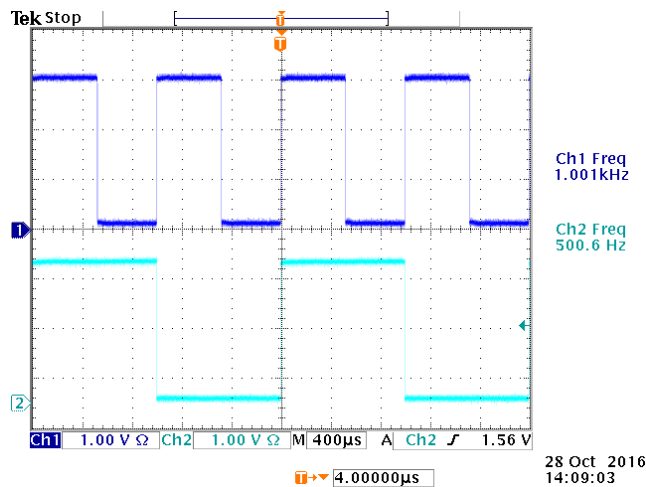


Figure 8. Frequency Division

## 10 Power Supply Recommendations

The power supply can be any voltage between the minimum and maximum supply voltage rating listed in the *Recommended Operating Conditions* table. A 0.1- $\mu$ F bypass capacitor is recommended to be connected from the VCC terminal to GND to prevent power disturbance. To reject different frequencies of noise, use multiple bypass capacitors in parallel. Capacitors with values of 0.1  $\mu$ F and 1  $\mu$ F are commonly used in parallel. The bypass capacitor must be installed as close to the power terminal as possible for best results.

## 11 Layout

### 11.1 Layout Guidelines

When a printed-circuit board (PCB) trace turns a corner at a 90° angle, a reflection can occur. A reflection occurs primarily because of the change of width of the trace. At the apex of the turn, the trace width increases to 1.414 times the width. This increase upsets the transmission-line characteristics, especially the distributed capacitance and self-inductance of the trace which results in the reflection. Not all PCB traces can be straight and therefore some traces must turn corners. Figure 9 shows progressively better techniques of rounding corners. Only the last example (BEST) maintains constant trace width and minimizes reflections.

### 11.2 Layout Example

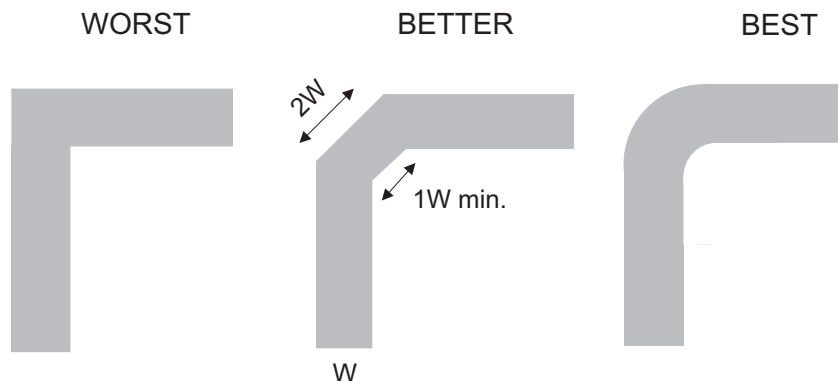


Figure 9. Trace Example

## 12 Device and Documentation Support

### 12.1 Documentation Support

#### 12.1.1 Related Documentation

For related documentation see the following:

- [Implications of Slow or Floating CMOS Inputs](#)
- [Designing and Manufacturing with TI's X2SON Packages](#)
- [How to Select Little Logic](#)
- [Introduction to Logic](#)
- [Power-Up Behavior of Clocked Devices](#)
- [Understanding Schmitt Triggers](#)
- [Semiconductor Packing Material Electrostatic Discharge \(ESD\) Protection](#)

#### 12.2 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on ti.com. In the upper right corner, click on *Alert me* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

#### 12.3 Community Resources

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**Design Support** *TI's Design Support* Quickly find helpful E2E forums along with design support tools and contact information for technical support.

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#### 12.5 Electrostatic Discharge Caution



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

#### 12.6 Glossary

[SLYZ022](#) — *TI Glossary*.

This glossary lists and explains terms, acronyms, and definitions.

## 13 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

**PACKAGING INFORMATION**

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead/Ball Finish (6)	MSL Peak Temp (3)	Op Temp (°C)	Device Marking (4/5)	Samples
SN74AUP1G80DBVR	ACTIVE	SOT-23	DBV	5	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	H80R	<a href="#">Samples</a>
SN74AUP1G80DBVRG4	ACTIVE	SOT-23	DBV	5	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	H80R	<a href="#">Samples</a>
SN74AUP1G80DBVT	ACTIVE	SOT-23	DBV	5	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	H80R	<a href="#">Samples</a>
SN74AUP1G80DBVTG4	ACTIVE	SOT-23	DBV	5	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	H80R	<a href="#">Samples</a>
SN74AUP1G80DCKR	ACTIVE	SC70	DCK	5	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	(HX5, HXF, HXK, HXO, HXR)	<a href="#">Samples</a>
SN74AUP1G80DCKRE4	ACTIVE	SC70	DCK	5	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	(HX5, HXF, HXK, HXO, HXR)	<a href="#">Samples</a>
SN74AUP1G80DCKRG4	ACTIVE	SC70	DCK	5	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	(HX5, HXF, HXK, HXO, HXR)	<a href="#">Samples</a>
SN74AUP1G80DCKT	ACTIVE	SC70	DCK	5	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	(HX5, HXO, HXR)	<a href="#">Samples</a>
SN74AUP1G80DCKTG4	ACTIVE	SC70	DCK	5	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	(HX5, HXO, HXR)	<a href="#">Samples</a>
SN74AUP1G80DPWR	ACTIVE	X2SON	DPW	5	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	BC	<a href="#">Samples</a>
SN74AUP1G80DRYR	ACTIVE	SON	DRY	6	5000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	HX	<a href="#">Samples</a>
SN74AUP1G80DSFR	ACTIVE	SON	DSF	6	5000	Green (RoHS & no Sb/Br)	CU NIPDAU   CU NIPDAUAG	Level-1-260C-UNLIM	-40 to 85	HX	<a href="#">Samples</a>
SN74AUP1G80YFPR	ACTIVE	DSBGA	YFP	6	3000	Green (RoHS & no Sb/Br)	SNAGCU	Level-1-260C-UNLIM		HXN	<a href="#">Samples</a>
SN74AUP1G80YZPR	ACTIVE	DSBGA	YZP	5	3000	Green (RoHS & no Sb/Br)	SNAGCU	Level-1-260C-UNLIM	-40 to 85	HXN	<a href="#">Samples</a>

(1) The marketing status values are defined as follows:

**ACTIVE:** Product device recommended for new designs.

**LIFEBUY:** TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

**NRND:** Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

**PREVIEW:** Device has been announced but is not in production. Samples may or may not be available.

**OBSELETE:** TI has discontinued the production of the device.

<sup>(2)</sup> **RoHS:** TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

**RoHS Exempt:** TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

**Green:** TI defines "Green" to mean the content of Chlorine (Cl) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of  $\leq 1000$ ppm threshold. Antimony trioxide based flame retardants must also meet the  $\leq 1000$ ppm threshold requirement.

<sup>(3)</sup> MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

<sup>(4)</sup> There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

<sup>(5)</sup> Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "-" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

<sup>(6)</sup> Lead/Ball Finish - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.

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**TAPE AND REEL INFORMATION**

**QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE**


\*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
SN74AUP1G80DBVR	SOT-23	DBV	5	3000	180.0	8.4	3.23	3.17	1.37	4.0	8.0	Q3
SN74AUP1G80DBVT	SOT-23	DBV	5	250	180.0	8.4	3.23	3.17	1.37	4.0	8.0	Q3
SN74AUP1G80DCKR	SC70	DCK	5	3000	180.0	9.2	2.3	2.55	1.2	4.0	8.0	Q3
SN74AUP1G80DCKR	SC70	DCK	5	3000	178.0	9.2	2.4	2.4	1.22	4.0	8.0	Q3
SN74AUP1G80DCKT	SC70	DCK	5	250	178.0	9.2	2.4	2.4	1.22	4.0	8.0	Q3
SN74AUP1G80DPWR	X2SON	DPW	5	3000	178.0	8.4	0.91	0.91	0.5	2.0	8.0	Q3
SN74AUP1G80DRYR	SON	DRY	6	5000	180.0	9.5	1.15	1.6	0.75	4.0	8.0	Q1
SN74AUP1G80DSFR	SON	DSF	6	5000	180.0	9.5	1.16	1.16	0.5	4.0	8.0	Q2
SN74AUP1G80YFPR	DSBGA	YFP	6	3000	178.0	9.2	0.89	1.29	0.62	4.0	8.0	Q1
SN74AUP1G80YZPR	DSBGA	YZP	5	3000	178.0	9.2	1.02	1.52	0.63	4.0	8.0	Q1

**TAPE AND REEL BOX DIMENSIONS**


\*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
SN74AUP1G80DBVR	SOT-23	DBV	5	3000	202.0	201.0	28.0
SN74AUP1G80DBVT	SOT-23	DBV	5	250	202.0	201.0	28.0
SN74AUP1G80DCKR	SC70	DCK	5	3000	205.0	200.0	33.0
SN74AUP1G80DCKR	SC70	DCK	5	3000	180.0	180.0	18.0
SN74AUP1G80DCKT	SC70	DCK	5	250	180.0	180.0	18.0
SN74AUP1G80DPWR	X2SON	DPW	5	3000	205.0	200.0	33.0
SN74AUP1G80DRYR	SON	DRY	6	5000	184.0	184.0	19.0
SN74AUP1G80DSFR	SON	DSF	6	5000	184.0	184.0	19.0
SN74AUP1G80YFPR	DSBGA	YFP	6	3000	220.0	220.0	35.0
SN74AUP1G80YZPR	DSBGA	YZP	5	3000	220.0	220.0	35.0

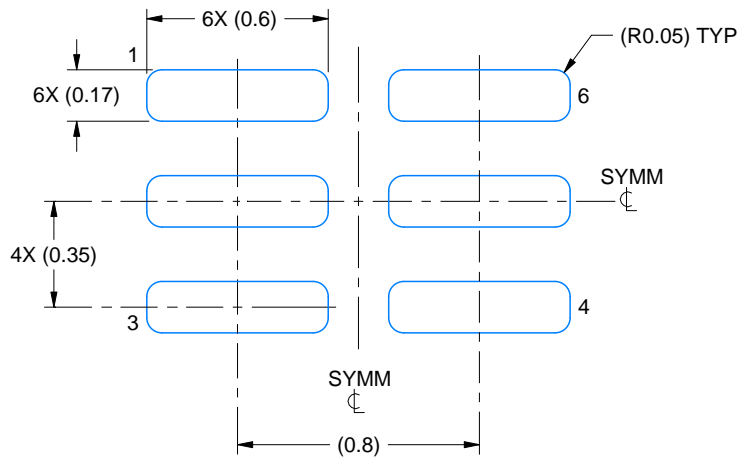


# EXAMPLE BOARD LAYOUT

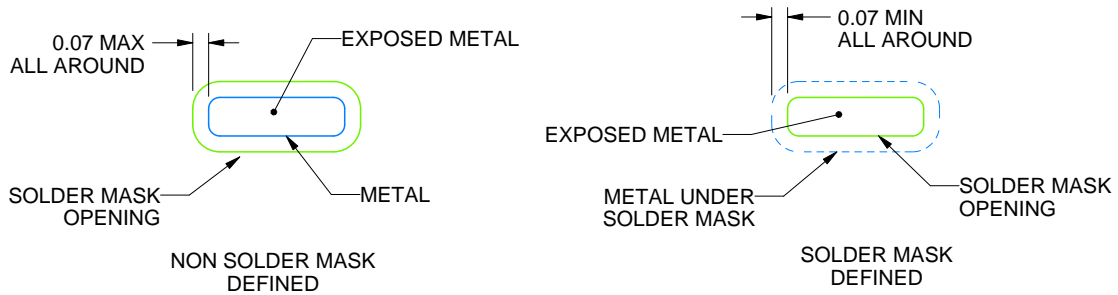
DSF0006A

X2SON - 0.4 mm max height

PLASTIC SMALL OUTLINE - NO LEAD



LAND PATTERN EXAMPLE  
EXPOSED METAL SHOWN  
SCALE:40X



SOLDER MASK DETAILS

4220597/A 06/2017

NOTES: (continued)

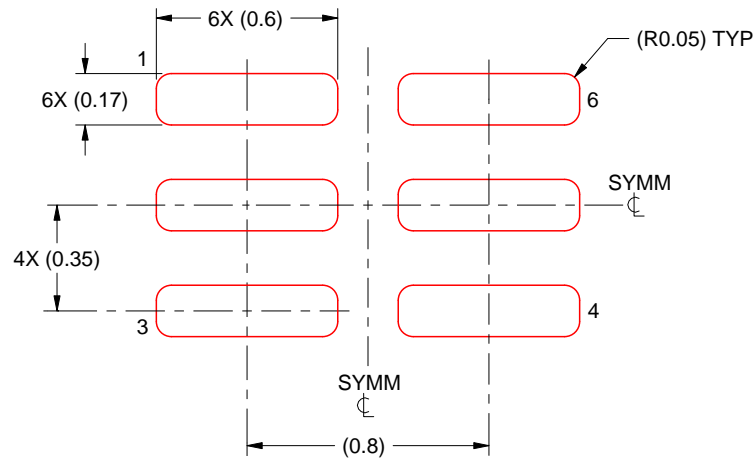
4. For more information, see Texas Instruments literature number SLUA271 ([www.ti.com/lit/slua271](http://www.ti.com/lit/slua271)).

# EXAMPLE STENCIL DESIGN

DSF0006A

X2SON - 0.4 mm max height

PLASTIC SMALL OUTLINE - NO LEAD



SOLDER PASTE EXAMPLE  
BASED ON 0.125 mm THICK STENCIL  
PRINTED SOLDER COVERAGE BY AREA UNDER PACKAGE  
SCALE:40X

4220597/A 06/2017

4. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.



# EXAMPLE BOARD LAYOUT

DBV0005A

SOT-23 - 1.45 mm max height

SMALL OUTLINE TRANSISTOR



LAND PATTERN EXAMPLE  
EXPOSED METAL SHOWN  
SCALE:15X



SOLDER MASK DETAILS

4214839/D 11/2018

NOTES: (continued)

- 5. Publication IPC-7351 may have alternate designs.
- 6. Solder mask tolerances between and around signal pads can vary based on board fabrication site.

# EXAMPLE STENCIL DESIGN

DBV0005A

SOT-23 - 1.45 mm max height

SMALL OUTLINE TRANSISTOR



SOLDER PASTE EXAMPLE  
BASED ON 0.125 mm THICK STENCIL  
SCALE:15X

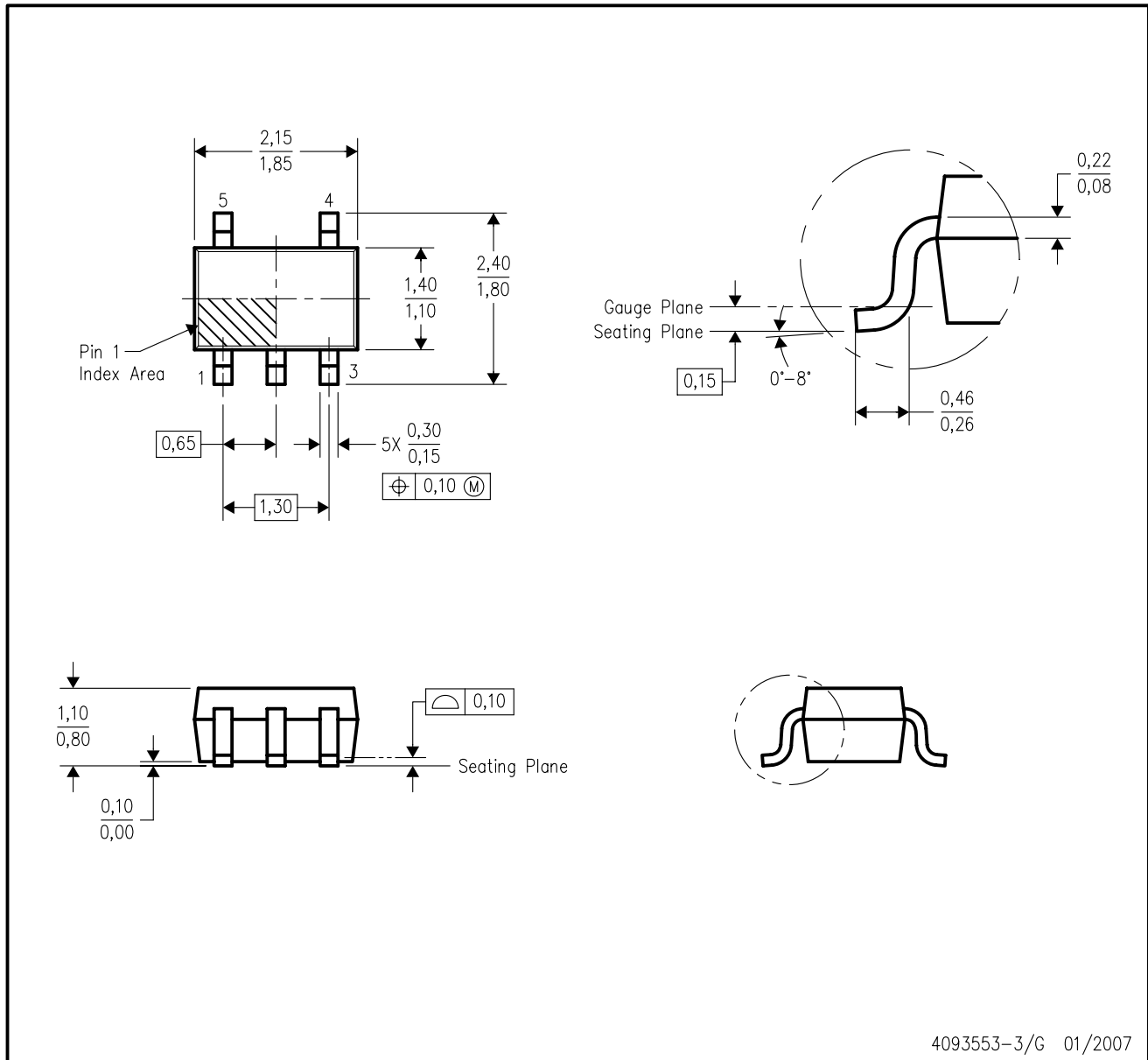
4214839/D 11/2018

NOTES: (continued)

7. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
8. Board assembly site may have different recommendations for stencil design.

DCK (R-PDSO-G5)

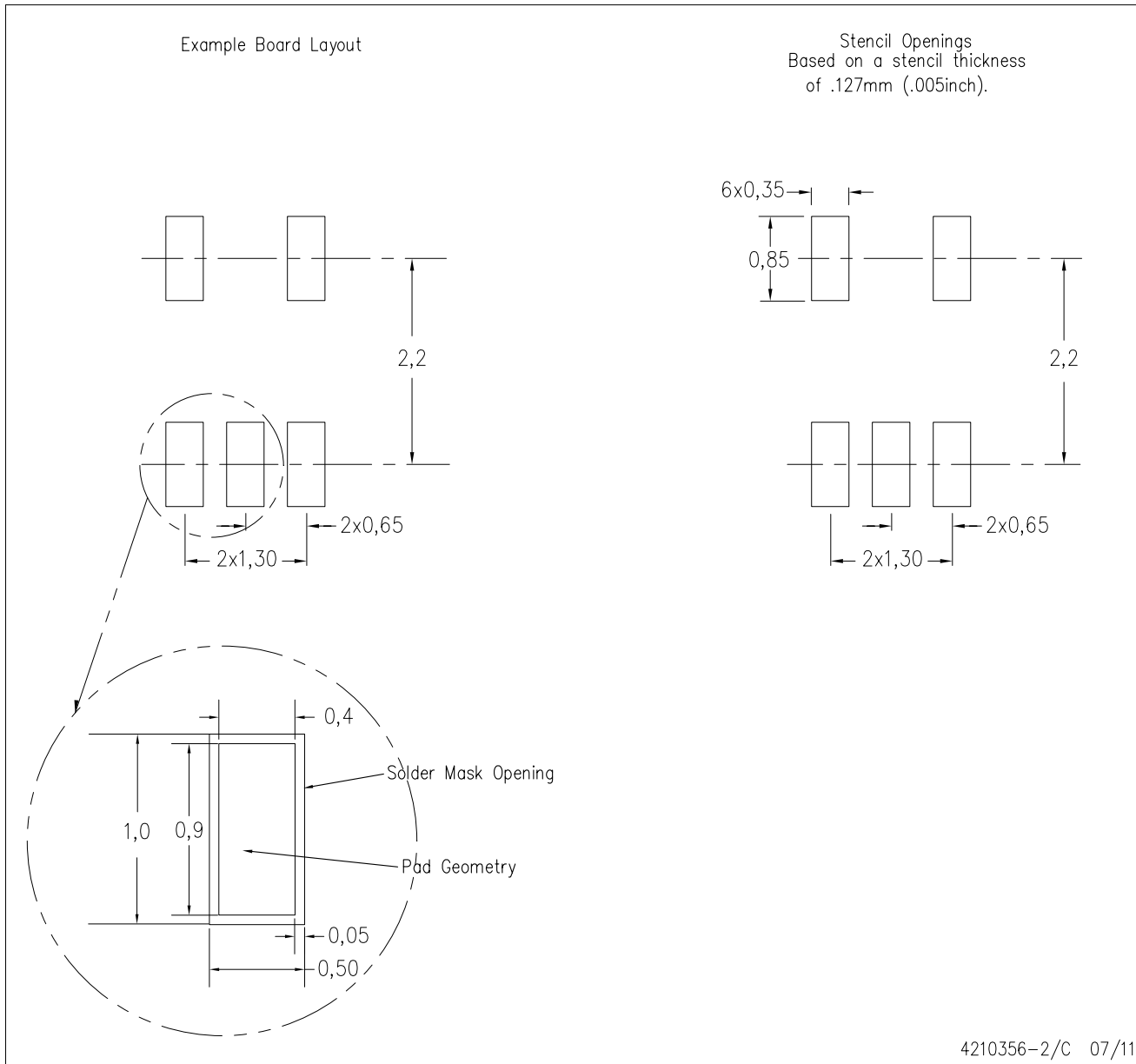
PLASTIC SMALL-OUTLINE PACKAGE



- NOTES:
- A. All linear dimensions are in millimeters.
  - B. This drawing is subject to change without notice.
  - C. Body dimensions do not include mold flash or protrusion. Mold flash and protrusion shall not exceed 0.15 per side.
  - D. Falls within JEDEC MO-203 variation AA.

DCK (R-PDSO-G5)

PLASTIC SMALL OUTLINE



- NOTES:
- All linear dimensions are in millimeters.
  - This drawing is subject to change without notice.
  - Customers should place a note on the circuit board fabrication drawing not to alter the center solder mask defined pad.
  - Publication IPC-7351 is recommended for alternate designs.
  - Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Example stencil design based on a 50% volumetric metal load solder paste. Refer to IPC-7525 for other stencil recommendations.

## GENERIC PACKAGE VIEW

**DRY 6**

**USON - 0.6 mm max height**

PLASTIC SMALL OUTLINE - NO LEAD



Images above are just a representation of the package family, actual package may vary.  
Refer to the product data sheet for package details.

4207181/G

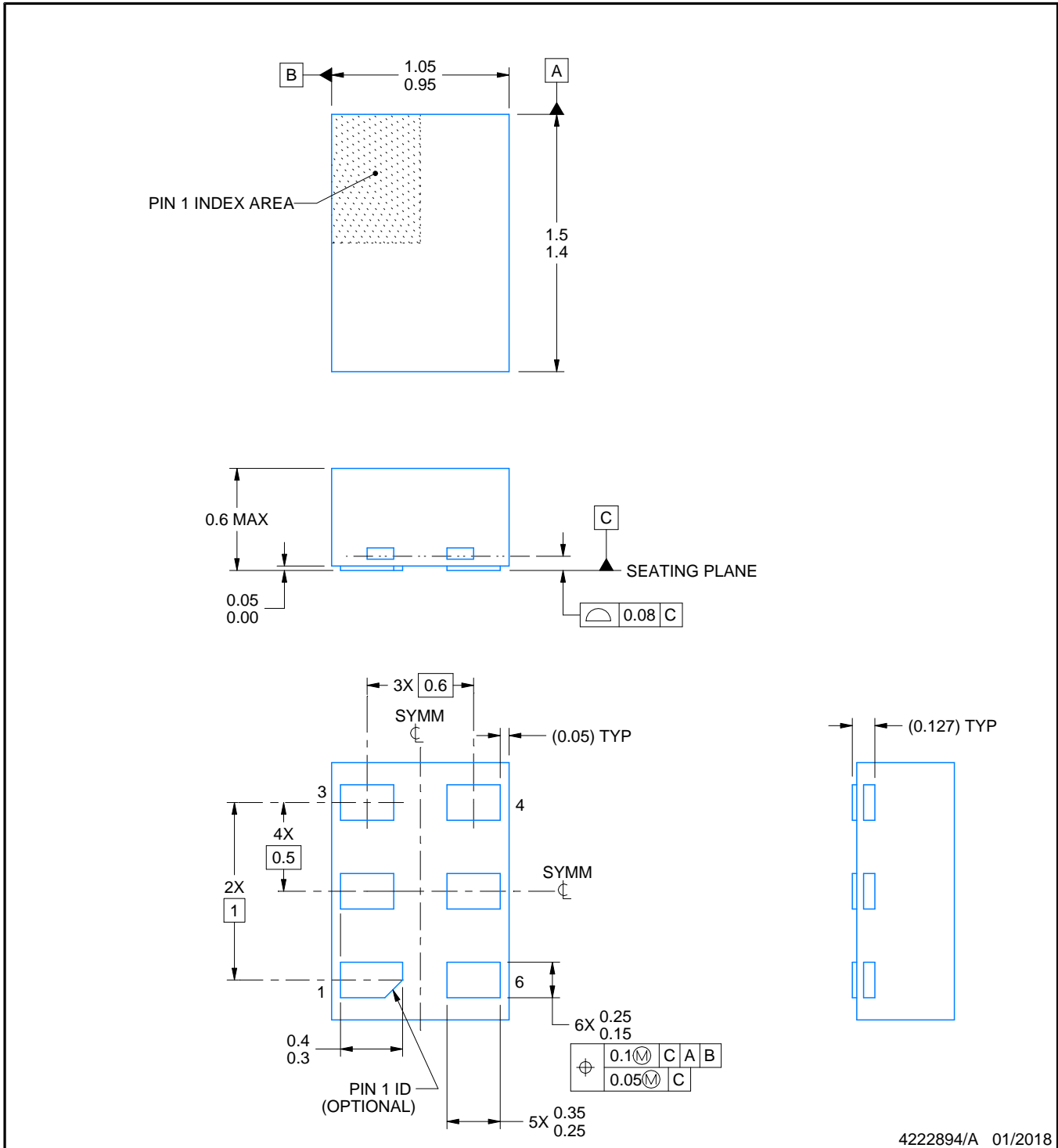
DRY0006A



# PACKAGE OUTLINE

USON - 0.6 mm max height

PLASTIC SMALL OUTLINE - NO LEAD



NOTES:

1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.

# EXAMPLE BOARD LAYOUT

DRY0006A

USON - 0.6 mm max height

PLASTIC SMALL OUTLINE - NO LEAD



**LAND PATTERN EXAMPLE**  
 1:1 RATIO WITH PKG SOLDER PADS  
 EXPOSED METAL SHOWN  
 SCALE:40X



**SOLDER MASK DETAILS**

4222894/A 01/2018

NOTES: (continued)

3. For more information, see QFN/SON PCB application report in literature No. SLUA271 ([www.ti.com/lit/slua271](http://www.ti.com/lit/slua271)).

# EXAMPLE STENCIL DESIGN

DRY0006A

USON - 0.6 mm max height

PLASTIC SMALL OUTLINE - NO LEAD



SOLDER PASTE EXAMPLE  
BASED ON 0.075 - 0.1 mm THICK STENCIL  
SCALE:40X

4222894/A 01/2018

NOTES: (continued)

4. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.

## GENERIC PACKAGE VIEW

DPW 5

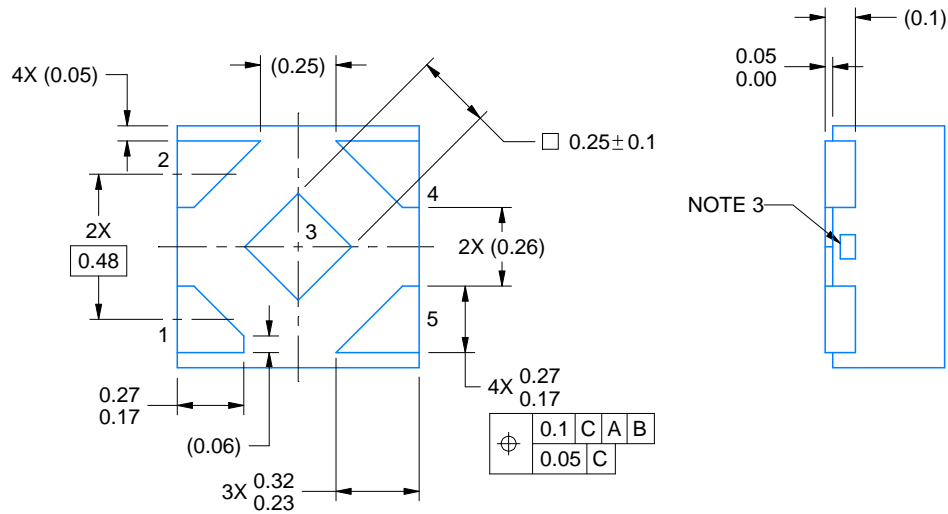
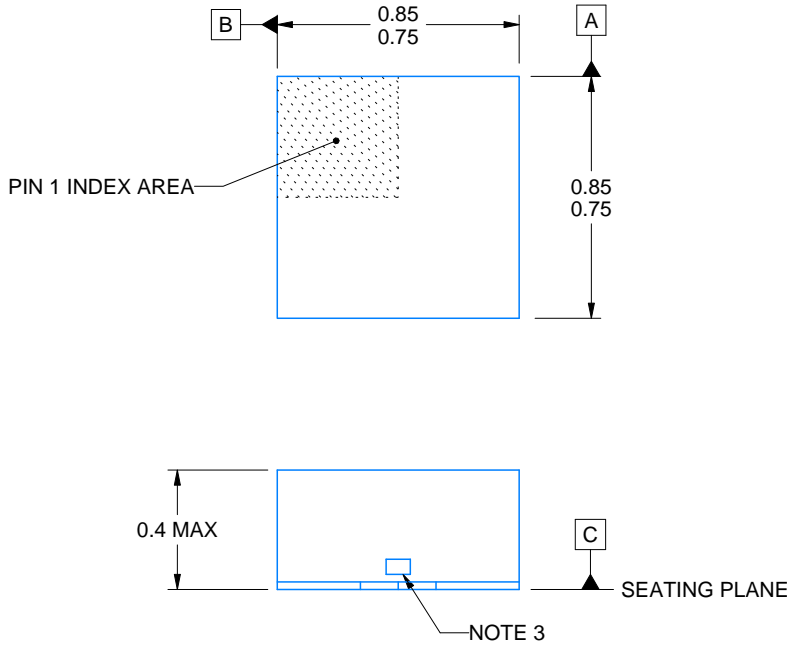
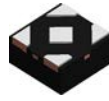
X2SON - 0.4 mm max height

PLASTIC SMALL OUTLINE - NO LEAD



Images above are just a representation of the package family, actual package may vary.  
Refer to the product data sheet for package details.

4211218-3/D



4223102/B 09/2017

NOTES:

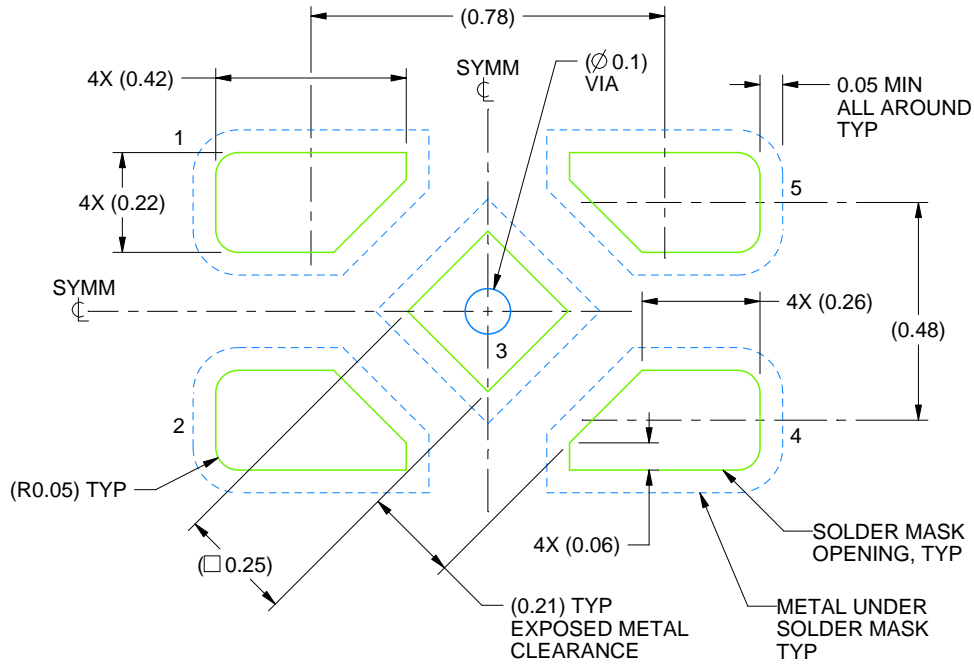
1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. The size and shape of this feature may vary.

# EXAMPLE BOARD LAYOUT

DPW0005A

X2SON - 0.4 mm max height

PLASTIC SMALL OUTLINE - NO LEAD



LAND PATTERN EXAMPLE  
SOLDER MASK DEFINED  
SCALE:60X

4223102/B 09/2017

NOTES: (continued)

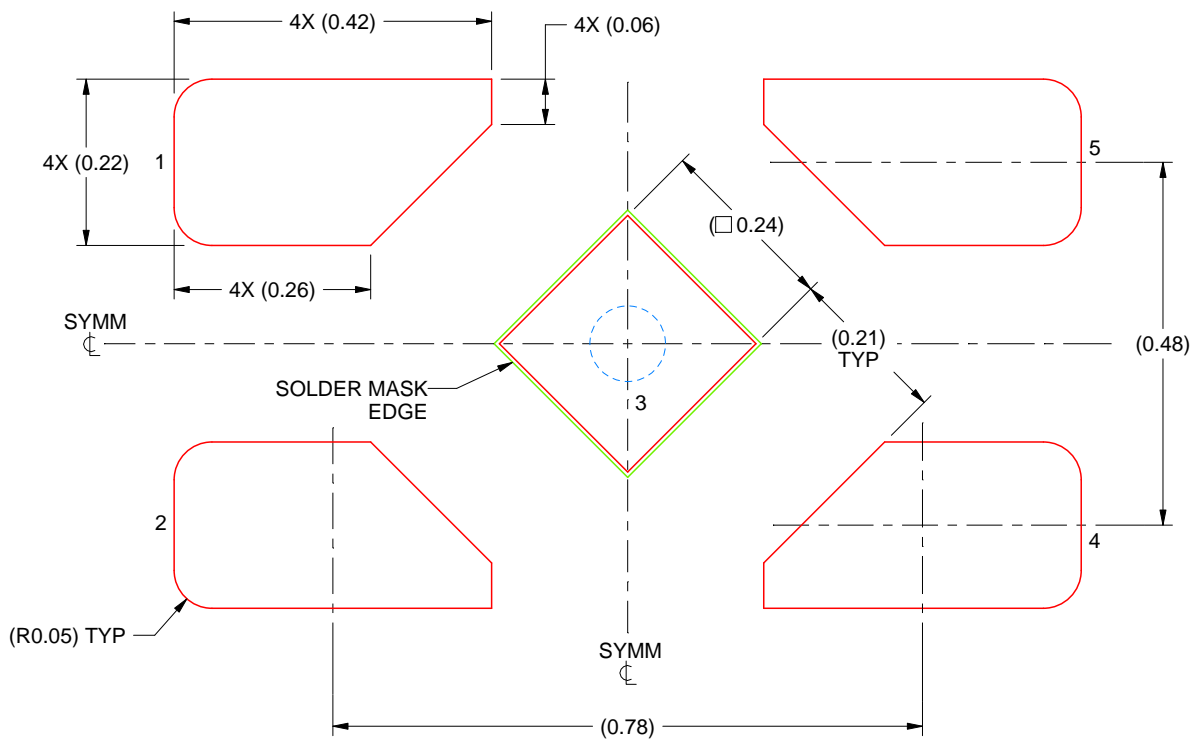
4. This package is designed to be soldered to a thermal pad on the board. For more information, refer to QFN/SON PCB application note in literature No. SLUA271 ([www.ti.com/lit/slua271](http://www.ti.com/lit/slua271)).

# EXAMPLE STENCIL DESIGN

DPW0005A

X2SON - 0.4 mm max height

PLASTIC SMALL OUTLINE - NO LEAD



SOLDER PASTE EXAMPLE  
BASED ON 0.1 mm THICK STENCIL

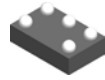
EXPOSED PAD  
92% PRINTED SOLDER COVERAGE BY AREA  
SCALE:100X

4223102/B 09/2017

NOTES: (continued)

5. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.

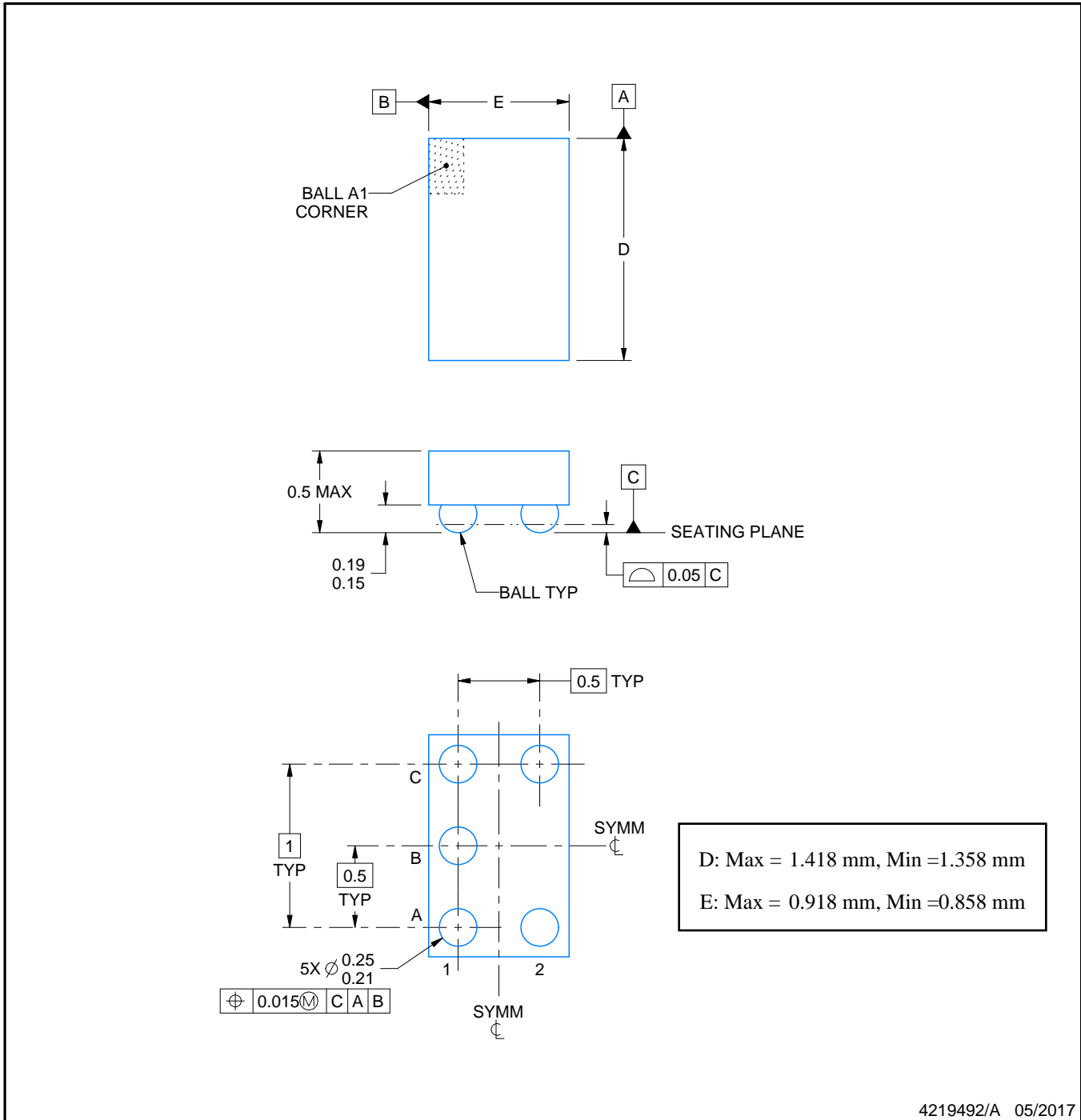
YZP0005



# PACKAGE OUTLINE

## DSBGA - 0.5 mm max height

DIE SIZE BALL GRID ARRAY



NOTES:

1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.

# EXAMPLE BOARD LAYOUT

YZP0005

DSBGA - 0.5 mm max height

DIE SIZE BALL GRID ARRAY



LAND PATTERN EXAMPLE  
SCALE:40X



SOLDER MASK DETAILS  
NOT TO SCALE

4219492/A 05/2017

NOTES: (continued)

- Final dimensions may vary due to manufacturing tolerance considerations and also routing constraints. For more information, see Texas Instruments literature number SNVA009 ([www.ti.com/lit/snva009](http://www.ti.com/lit/snva009)).

# EXAMPLE STENCIL DESIGN

YZP0005

DSBGA - 0.5 mm max height

DIE SIZE BALL GRID ARRAY



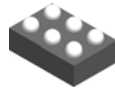
SOLDER PASTE EXAMPLE  
BASED ON 0.1 mm THICK STENCIL  
SCALE:40X

4219492/A 05/2017

NOTES: (continued)

4. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release.

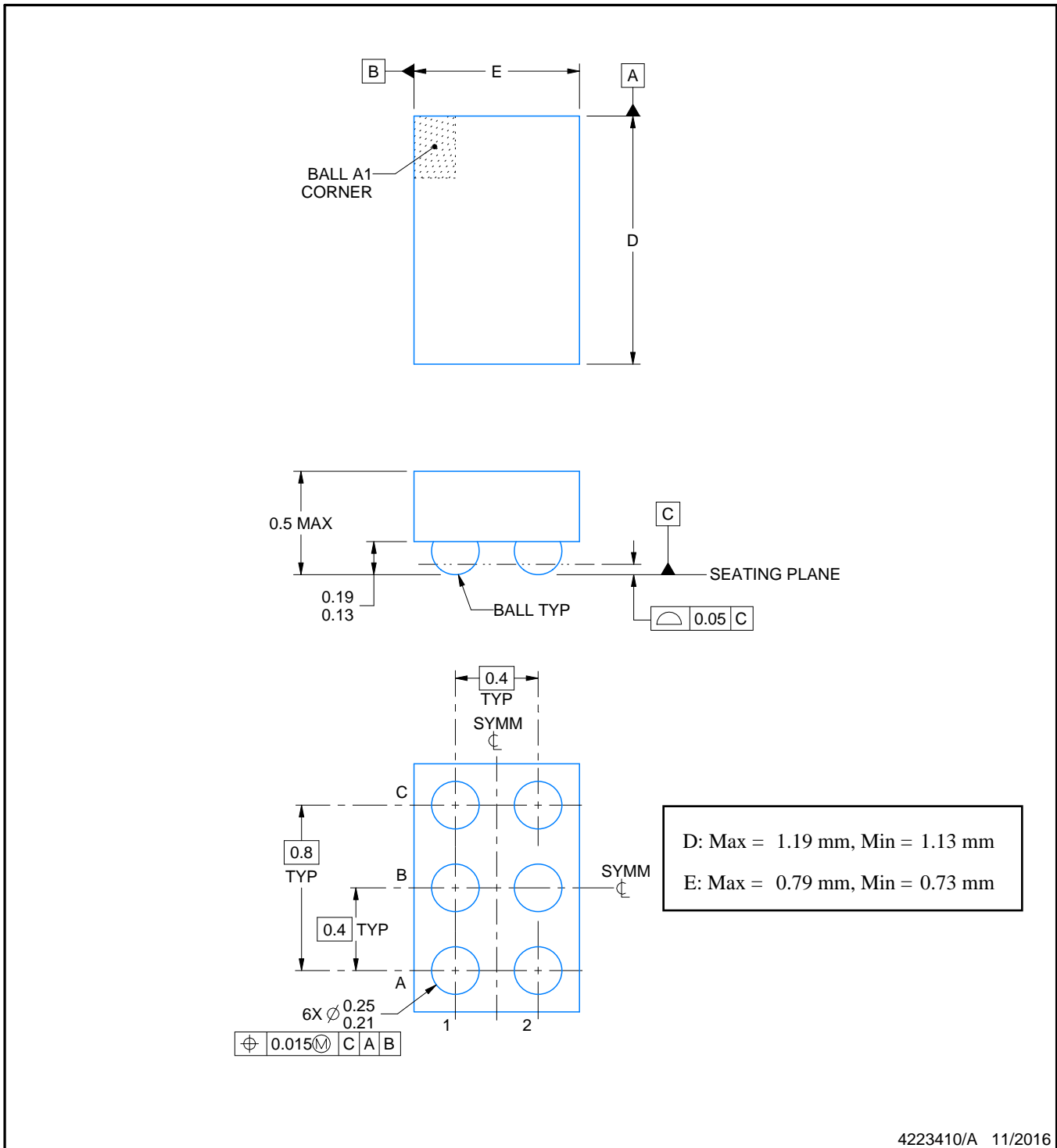
YFP0006



# PACKAGE OUTLINE

DSBGA - 0.5 mm max height

DIE SIZE BALL GRID ARRAY



4223410/A 11/2016

NOTES:

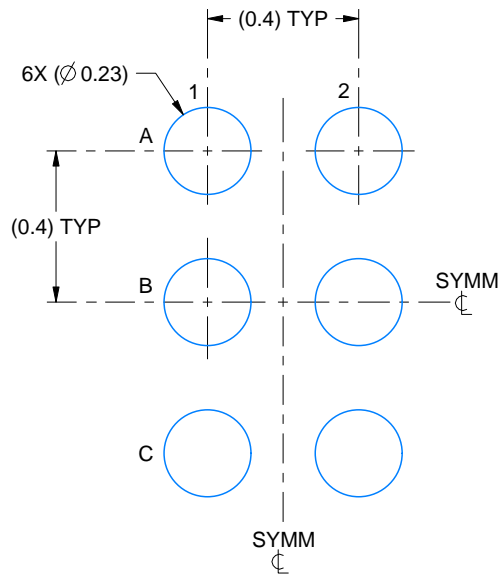
1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.

# EXAMPLE BOARD LAYOUT

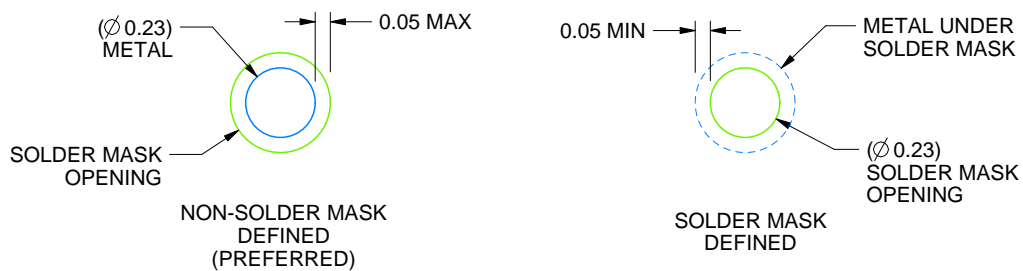
YFP0006

DSBGA - 0.5 mm max height

DIE SIZE BALL GRID ARRAY



LAND PATTERN EXAMPLE  
SCALE:50X



SOLDER MASK DETAILS  
NOT TO SCALE

4223410/A 11/2016

NOTES: (continued)

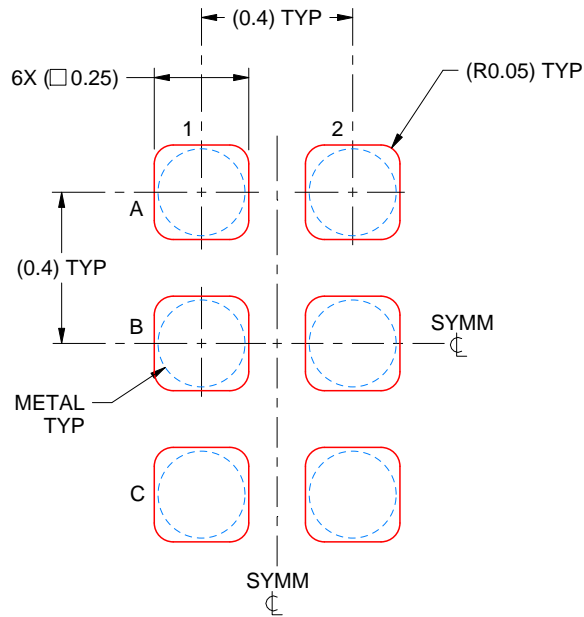
- Final dimensions may vary due to manufacturing tolerance considerations and also routing constraints. For more information, see Texas Instruments literature number SNVA009 ([www.ti.com/lit/snva009](http://www.ti.com/lit/snva009)).

# EXAMPLE STENCIL DESIGN

YFP0006

DSBGA - 0.5 mm max height

DIE SIZE BALL GRID ARRAY



SOLDER PASTE EXAMPLE  
BASED ON 0.1 mm THICK STENCIL  
SCALE:50X

4223410/A 11/2016

NOTES: (continued)

4. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release.

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